

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO.	SERIAL NO.
		210287US2	09/892,697
		APPLICANT	
		Kiyoshi HIDAKA, et al.	
LIST OF REFERENCES CITED BY APPLICANT		FILING DATE	GROUP
		June 28, 2001	2675

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Technology Center 2600

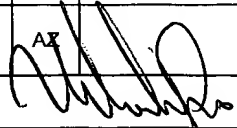
U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
W	AO	10-105505	04/24/98	JAPAN (with English Abstract)		X
W	AP	63-234319	09/29/88	JAPAN (with English Abstract)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	
Examiner 		<input type="checkbox"/> Additional References sheet(s) attached
		Date Considered August 21, 2002

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
210287US2SERIAL NO.
NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Kiyoshi HIDAKA, et al.

FILING DATE
HEREWITH

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
WFO	AA	5,339,160	08/16/94	Hiroyasu SHINDOU	348	571	
WFO	AB	5,864,512	01/26/99	Matt E. BUCKELEW, et al.	365	230-01	
	AC						
	AD						
	AE						
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	AH						
	AI						
	AJ						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
WFO	AO	2000-122630	04/28/00	JAPAN (with English Abstract)		X
WFO	AP	5-303361	11/16/93	JAPAN (with English Abstract) (Corresponding U.S. Patent 5,339,160)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

Date Considered

August 21, 2002

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05/28/01